

Joint ICTP-IAEA Workshop on Modelling for Encapsulated Intermediate
Level Waste (ILW) and High Level Waste (HLW) During Long-Term
Storage | (smr 3920)

Contribution ID : 47

Type : **not specified**

Model the transport of charged ions in matter using code SRIM/TRIM

Tuesday, 27 February 2024 13:50 (0:40)

Content

(Electronic energy loss versus penetration depth (or versus energy) curves)

Interactive session: Tutorial based modelling exercises in computer facility LBLab (LB)

Summary

Presenter(s) : MAIK LANG (University of Tennessee, USA)

Session Classification : Radiation modelling using SRIM/TRIM codes